

Improved Prism Array for Electron Beam Inspection and Defect Review

Inventor(s): Marian Mankos
Atty Docket No. 10011.002400 (P1266)

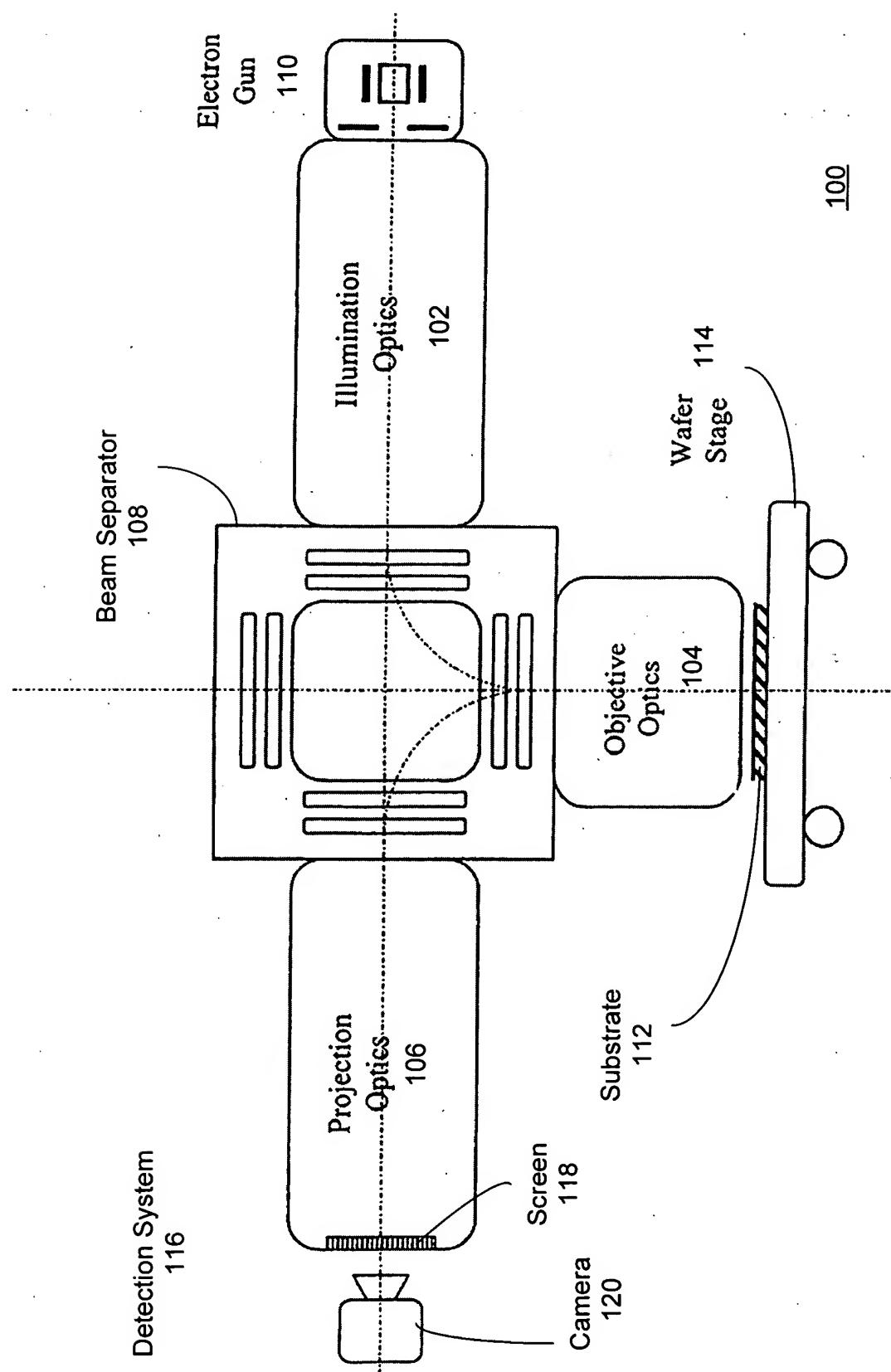


FIG. 1

*Improved Prism Array for Electron Beam Inspection
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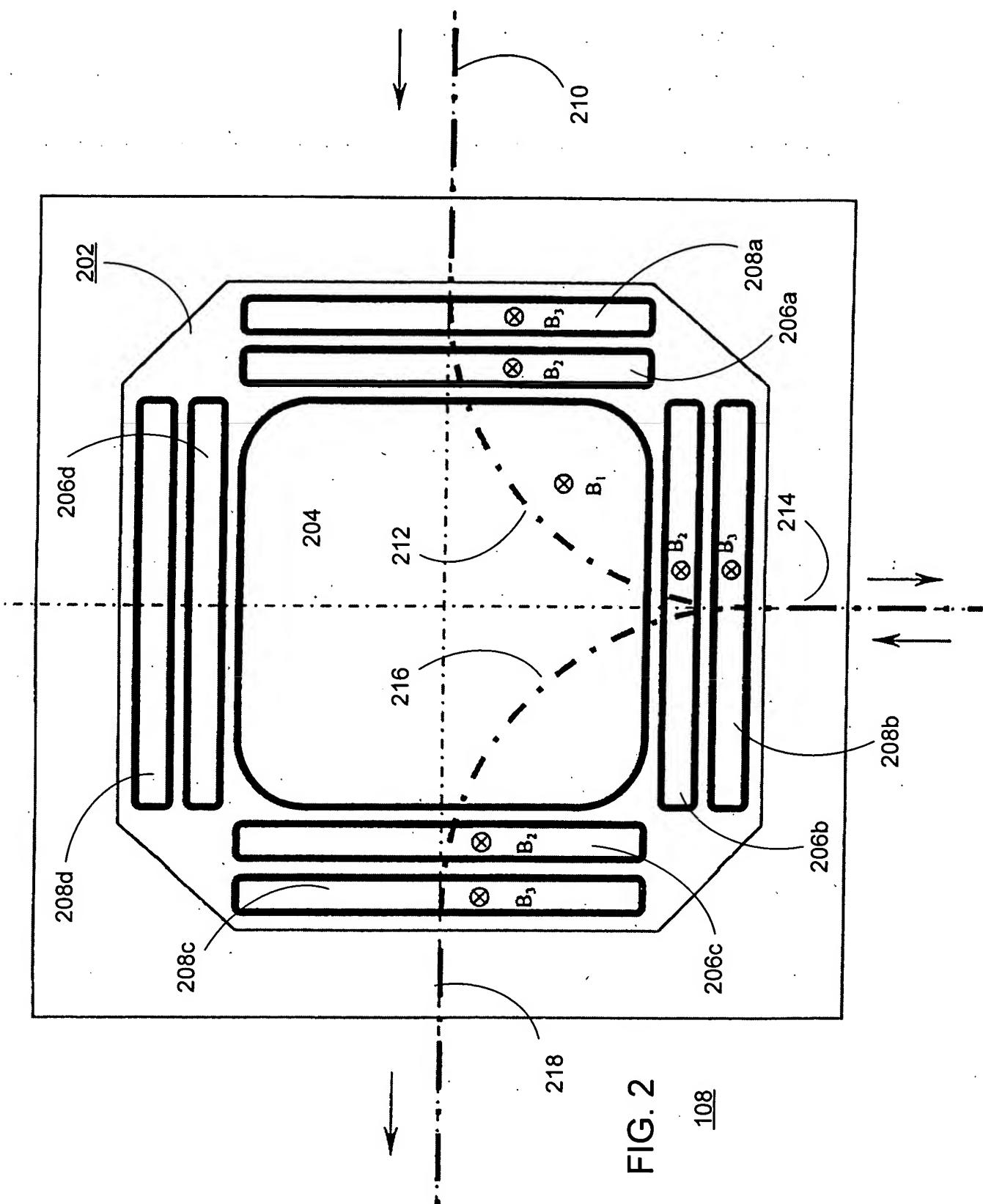


FIG. 2
108

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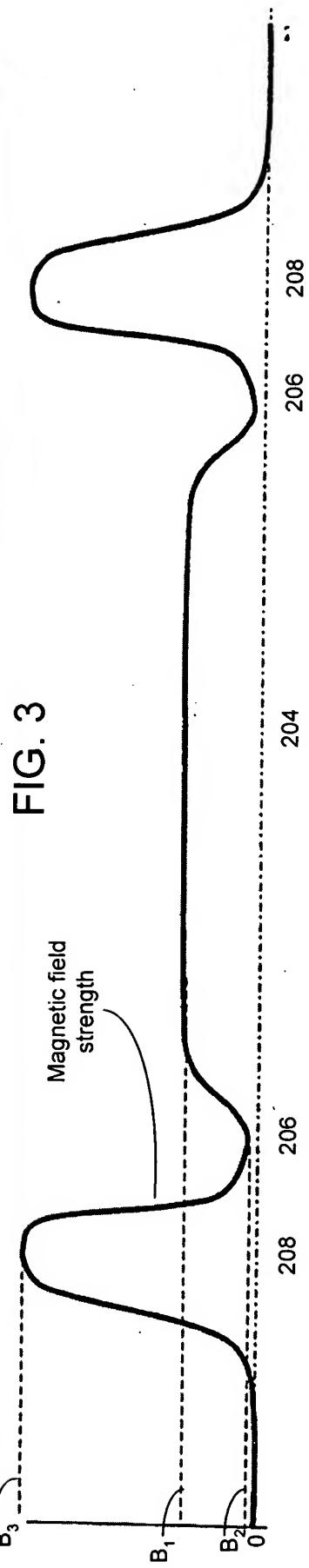
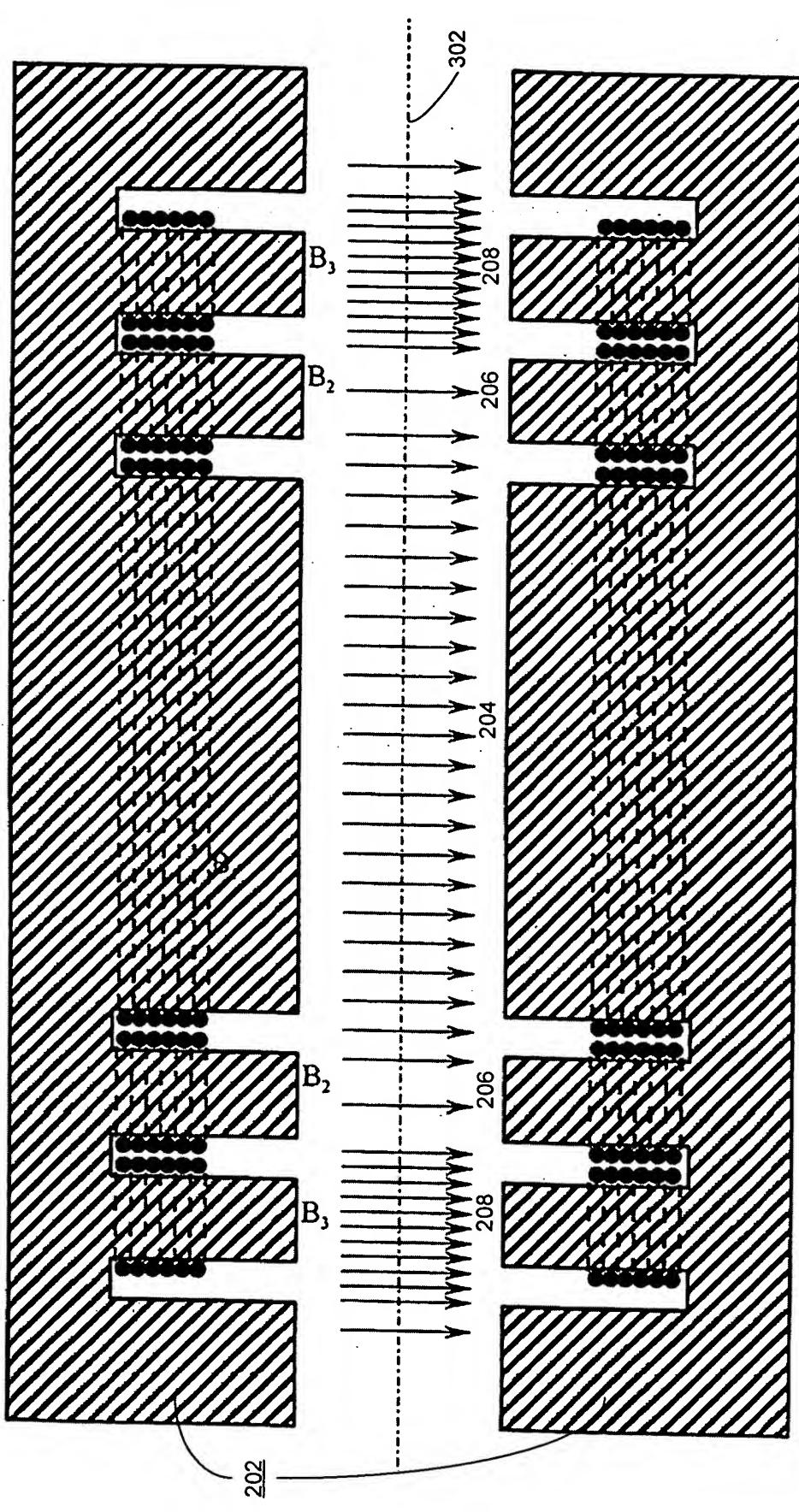


FIG. 3

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